## **U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB		٠				
	AC						
	AD						
	AE						

## **FOREIGN PATENT DOCUMENTS**

	DOCUMENT NO.	DATE	COUNTRY	TRANSL YES	ATION NO	ABSTRACT
AF						
AG						
АН						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)				
,	AI	Korean Office Action issued on November 25, 2002, in Korean Patent Application No. 2001-5374 (in Korean with English translation)	х	
,	AJ	European Search Report issued on November 28, 2003, in European Patent Application No. 0131066.1		
,	AK	Japanese Office Action issued on April 13, 2004, in Japanese Patent Application No. 2001-398557 (in Japanese, no English translation)		Х
,	AL	Japanese Office Action issued on August 31, 2004, in Japanese Patent Application No. 2001-398557 (in Japanese, no English translation)		Х

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